

FAN1654

1.5A LDO, DDR Bus Termination Regulator

Features

- Sinks and sources 1A continuous, 1.5A peak
- -40°C to +125°C Operating Range
- Load regulation: $(VDDQ/2) \pm 40mV$
- 5mA VREF buffer tracks VTT
- On-chip thermal limiting
- Power-enhanced eTSSOP™-16 package
- Low Current Shutdown Mode
- Output Short Circuit Protection

Applications

- DDR terminators

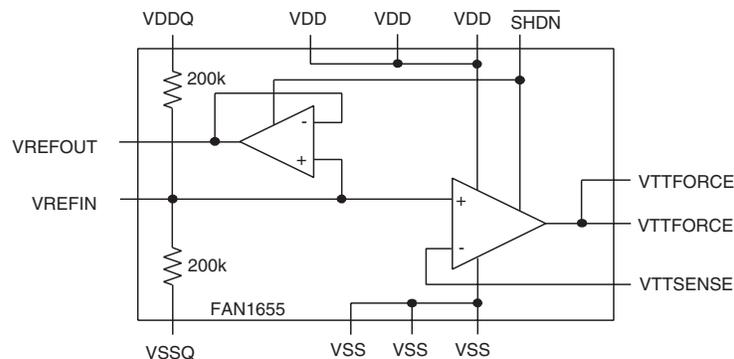
Description

The FAN1654 is a low-cost bi-directional LDO specifically designed for terminating DDR memory bus. It can both sink and source up to 1A continuous, 1.5A peak, providing enough current for most DDR applications. Load regulation meets the JEDEC spec, $VTT = (VDDQ/2) \pm 40mV$.

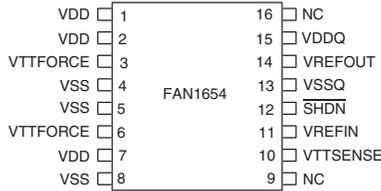
The FAN1654 includes a buffered reference voltage capable of supplying up to 5mA current. On-chip thermal limiting provides protection against a combination of power overload and ambient temperature that would create an excessive junction temperature. A shutdown input puts the FAN1654 into a low power mode for laptop computer applications.

The FAN1654 regulator is available in a power-enhanced eTSSOP™-16 package, and the standard SOIC-14

Block Diagram



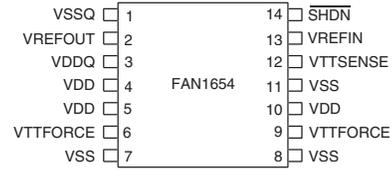
Pin Assignments



16-Lead Plastic eTSSOP-16

$$\theta_{JC} = 4^{\circ}\text{C/W}^*$$

*With package power slug soldered to 0.5 square inch copper area over backside ground plane of internal power plane



14-Lead Plastic SOIC

$$\theta_{JC} = 37^{\circ}\text{C/W}, \theta_{JA} = 88^{\circ}\text{C/W}$$

Pin Definitions

| Pin Number* | Pin Name | Pin Function Description |
|--------------------|----------|---|
| 1, 2, 7 (4, 5, 10) | VDD | VDD. Input power for the LDO. |
| 3, 6 (6, 9) | VTTFORCE | VTT Force Output. |
| 4, 5, 8 (7, 8, 11) | VSS | Power Ground. |
| 10 (12) | VTTSENSE | VTT Sense. Feedback for remote sense of the VTT voltage. |
| 11 (13) | VREFIN | VREFIN. Alternative input for direct control of VTTOUT and VREFOUT. |
| 12 (14) | SHDN | Shutdown. This active low shutdown turns off both VTT and VREFOUT. This pin has an internal pull-down, and must be externally driven high for the IC to be on. |
| 13 (1) | VSSQ | Signal Ground. |
| 14 (2) | VREFOUT | Buffered Voltage Reference Output. |
| 15 (3) | VDDQ | VDDQ Input. Attach this pin to the VDDQ supply to generate VTT and VREFOUT. |
| 9,16 | NC | No Internal Connection |

* Pin Numbers in brackets are for the SOIC-14 package

Typical Application

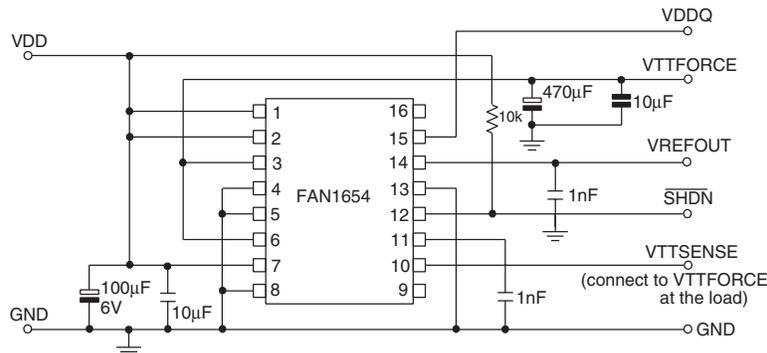


Figure 1. (eTSSOP pinout shown)

Typical Performance Characteristics

Quiescent Current vs. Temperature

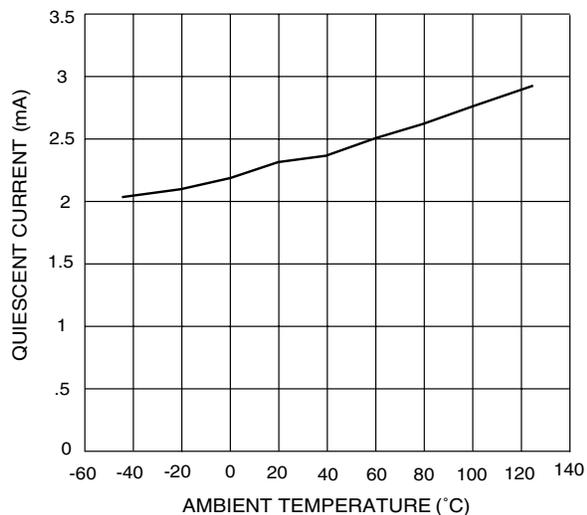


Figure 2

VREF Output Change vs. IREF

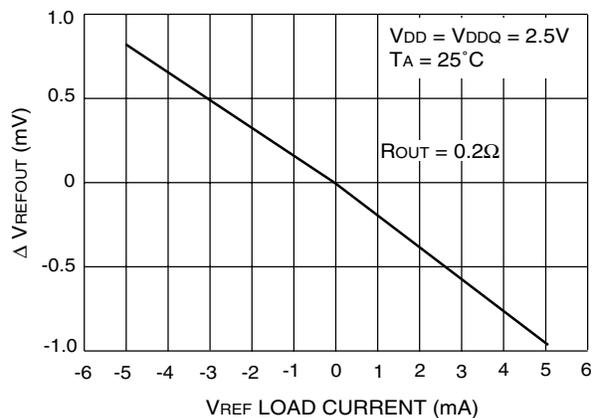


Figure 3

VTT Load Current

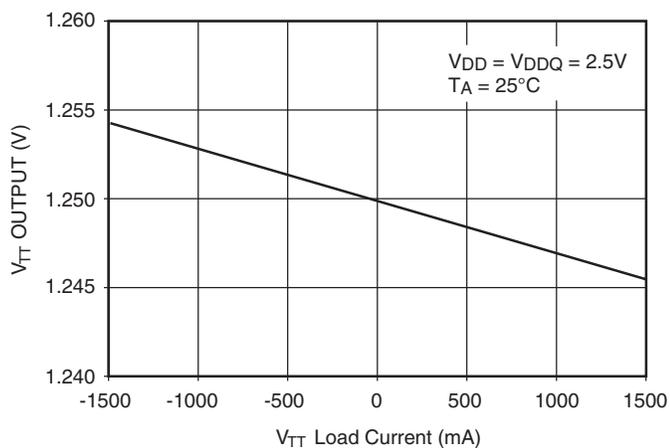


Figure 4

Absolute Maximum Ratings

| | |
|--|--------------|
| Supply Voltage VDD, VDDQ | 6V |
| Junction Temperature, T _J | 150°C |
| Storage Temperature | -65 to 150°C |
| Lead Soldering Temperature, 10 seconds | 300°C |
| Power Dissipation, P _D | 1.4W |

Recommended Operating Conditions

| Parameter | Conditions | Min. | Typ. | Max. | Units |
|-------------------------------|------------|------|------|------|-------|
| Supply Voltage VDD | | 2.3 | 2.5 | 3.6 | V |
| Supply Voltage VDDQ | | 2.2 | 2.5 | 3.0 | V |
| Ambient Operating Temperature | | -40 | | 125 | °C |
| VREFIN | | 1.1 | 1.25 | 1.5 | V |

Electrical Characteristics

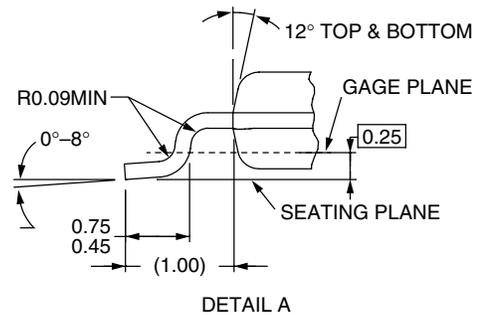
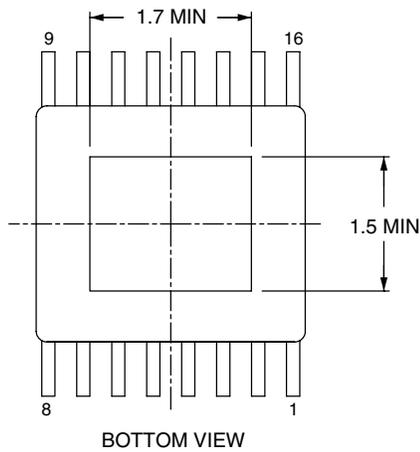
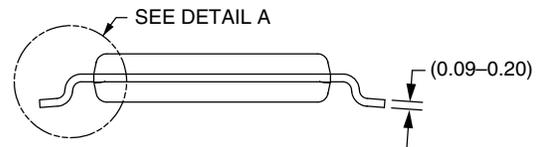
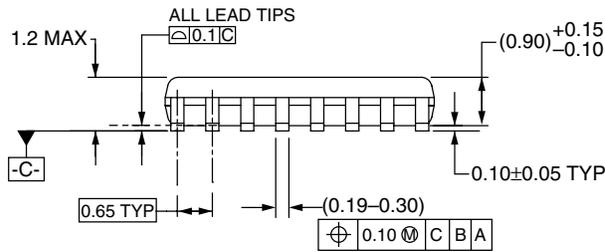
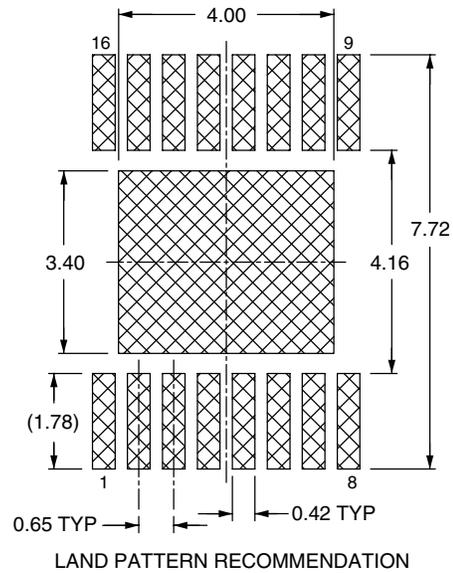
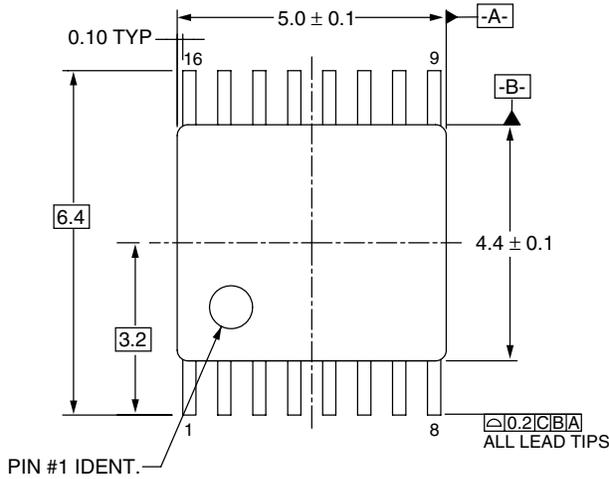
(VDD = VDDQ = 2.5V ± 0.2V, and T_A = 25°C using circuit in Figure 1, unless otherwise noted.)

The • denotes specifications which apply over the specified operating temperature range.

| Parameter | Conditions | Min. | Typ. | Max. | Units | |
|-----------------------------|---------------------------------------|-------------------|-------|-------|--------|----|
| VTT Output Voltage | I _{OUT} = 0A, VREFIN = open | VDDQ = 2.3V • | 1.135 | 1.150 | 1.165 | V |
| | | VDDQ = 2.5V • | 1.235 | 1.250 | 1.265 | V |
| | | VDDQ = 2.7V • | 1.335 | 1.350 | 1.365 | V |
| | I _{OUT} = ±1A, VREFIN = open | VDDQ = 2.3V | 1.110 | 1.150 | 1.190 | V |
| | | VDDQ = 2.5V | 1.210 | 1.250 | 1.290 | V |
| | | VDDQ = 2.7V | 1.310 | 1.350 | 1.390 | V |
| VTT Output Slew Rate | Cload = 10μF | | 0.1 | | V/μsec | |
| VTT Leakage Current | SHDN = 0V | • -50 | | 50 | μA | |
| VTT Current Limit | | | ±2 | | A | |
| VREFIN Input Impedance | | | 100 | | KΩ | |
| VREFOUT Output Voltage | No load | VREFIN = 1.150V • | 1.145 | 1.150 | 1.155 | V |
| | | VREFIN = 1.250V • | 1.245 | 1.250 | 1.255 | V |
| | | VREFIN = 1.350V • | 1.345 | 1.350 | 1.355 | V |
| | | VDDQ = 2.3V | • -5 | | 5 | mA |
| VREFOUT Output Current | VDDQ = 2.3V | • -5 | | 5 | mA | |
| VREFOUT Leakage Current | SHDN = 0V | • -10 | | 10 | μA | |
| SHDN Logic High | | • 1.667 | | | V | |
| SHDN Logic Low | | • | | 0.800 | V | |
| IDD Supply Current | No load, SHDN = 2.7V | • | 3 | 10 | mA | |
| VDDQ Leakage Current | SHDN = 0V | • | 6 | 10 | μA | |
| VDD Leakage Current | SHDN = 0V | • | 3 | 50 | μA | |
| SHDN Input Current | SHDN = 2.7V | • | 50 | 75 | μA | |
| Over-Temperature Shutdown | | | 155 | | °C | |
| Over-Temperature Hysteresis | | | 30 | | °C | |

Mechanical Dimensions

16 Lead eTSSOP



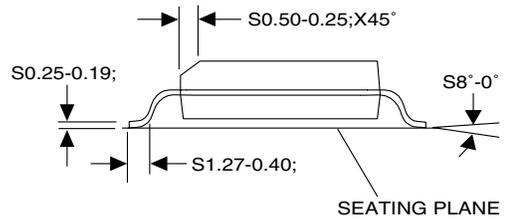
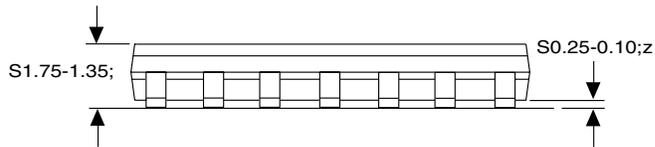
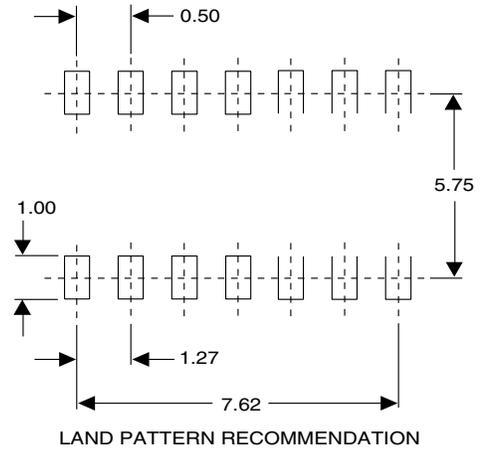
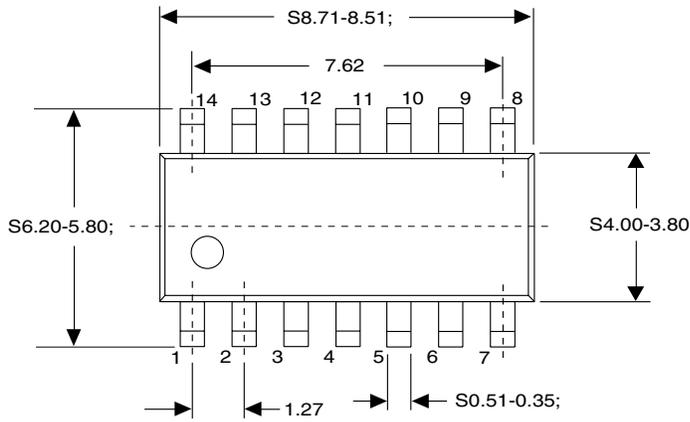
- NOTES:
- A. CONFORMS TO JEDEC REGISTRATION MO-153, VARIATION ABT, DATED 10/97.
 - B. DIMENSIONS ARE IN MILLIMETERS.
 - C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND THE BAR EXTENSIONS.
 - D. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994.

Mechanical Dimensions

14-Lead SOIC

NOTES:

1. This package conforms to JEDEC MS-012, variation AB, ISSUEC dated May, 1990.
2. All dimensions are in millimeters
3. Standard lead finished
 200 microinches / 5.08 microns min.
 Lead/Tin (solder) on copper



Ordering Information

| Product Number | Package |
|----------------|----------------------------|
| FAN1654MTF | eTSSOP-16 |
| FAN1654MTFX | eTSSOP-16 in tape and reel |
| FAN1654M | SOIC-14 |
| FAN1654MX | SOIC-14 in tape and reel |

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.